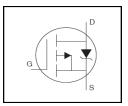


### **AUTOMOTIVE GRADE**

# AUIRF6215S

#### **Features**

- Advanced Planar Technology
- Low On-Resistance
- P-Channel MOSFET
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	-150V
R <sub>DS(on)</sub> max.	0.29Ω
I <sub>D</sub>	-13A



G	D	S
Gate	Drain	Source

## Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Door nort number	Dookogo Typo	Standard Pack		Ordershie Bert Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
ALUDEGO4EC	D <sup>2</sup> -Pak	Tube	50	AUIRF6215S
AUIRF6215S	D-Pak	Tape and Reel Left	800	AUIRF6215STRL

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-13	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V	-9.0	Α
I <sub>DM</sub>	Pulsed Drain Current ①	-44	
P <sub>D</sub> @T <sub>A</sub> = 25°C	Maximum Power Dissipation	3.8	10/
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.71	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>			mJ
I <sub>AR</sub>	Avalanche Current ①	-6.6	А
E <sub>AR</sub>	Repetitive Avalanche Energy ①	11	mJ
dv/dt			V/ns
TJ	Operating Junction and		
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

### **Thermal Resistance**

Symbol	Symbol Parameter		Max.	Units
$R_{ heta JC}$	Junction-to-Case®		1.4	°C 111
$R_{ heta JA}$	Junction-to-Ambient ( PCB Mount, steady state) ©		40	°C/W

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<sup>\*</sup>Qualification standards can be found at www.infineon.com



### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-150			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-0.20		V/°C	Reference to 25°C, I <sub>D</sub> = -1mA
D	Static Drain-to-Source On-Resistance			0.29		$V_{GS} = -10V, I_D = -6.6A \oplus$
$R_{DS(on)}$	Static Diam-to-Source On-Nesistance			0.58	Ω	$V_{GS} = -10V, I_D = -6.6A, T_J = 150$ °C ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$ , $I_D = -250\mu A$
g <sub>fs</sub>	Forward Trans conductance	3.6			S	$V_{DS} = -25V, I_{D} = -6.6A$
l	Drain-to-Source Leakage Current			-25		$V_{DS} = -150V, V_{GS} = 0V$
IDSS	Dialii-to-Source Leakage Current			-250	μΑ	$V_{DS} = -120V, V_{GS} = 0V, T_{J} = 150$ °C
$I_{GSS}$	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			-100	<b>π</b> Λ	$V_{GS} = -20V$
				100	nA	$V_{GS} = 20V$

## Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Total Gate Charge Gate-to-Source Charge			66		
Gate-to-Source Charge			00		$I_{D} = -6.6A$
Cate-to-cource charge			8.1	nC	$V_{DS} = -120V$
Gate-to-Drain Charge			35		V <sub>GS</sub> = -10V4
Turn-On Delay Time		14			$V_{DD} = -75V$
Rise Time		36		200	$I_D = -6.6A$
Turn-Off Delay Time		53		115	$R_G = 6.8\Omega$ ,
Fall Time		37			R <sub>D</sub> = 12Ω ④
Internal Source Inductance		7.5		nΗ	Between lead,6mm (0.25in.) from package and center of die contact
Input Capacitance		860			$V_{GS} = 0V$
Output Capacitance		220		рF	$V_{DS} = -25V$
Reverse Transfer Capacitance		130		-	f = 1.0MHz, See Fig.5
	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Internal Source Inductance Input Capacitance Output Capacitance	Turn-On Delay Time ————————————————————————————————————	Turn-On Delay Time         —         14           Rise Time         —         36           Turn-Off Delay Time         —         53           Fall Time         —         37           Internal Source Inductance         —         7.5           Input Capacitance         —         860           Output Capacitance         —         220	Turn-On Delay Time         —         14         —           Rise Time         —         36         —           Turn-Off Delay Time         —         53         —           Fall Time         —         37         —           Internal Source Inductance         —         7.5         —           Input Capacitance         —         860         —           Output Capacitance         —         220         —	Turn-On Delay Time         —         14         —           Rise Time         —         36         —           Turn-Off Delay Time         —         53         —           Fall Time         —         37         —           Internal Source Inductance         —         7.5         —         nH           Input Capacitance         —         860         —           Output Capacitance         —         220         —         pF

### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			-11	_	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			-44		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			-1.6	٧	$T_J = 25^{\circ}C, I_S = -6.6A, V_{GS} = 0V $ ④
t <sub>rr</sub>	Reverse Recovery Time		160	240	ns	$T_J = 25^{\circ}C$ , $I_F = -6.6A$
$Q_{rr}$	Reverse Recovery Charge		1.2	1.7	μC	di/dt = 100A/µs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	c turn-c	on time	is neglig	gible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)
- $\odot$  Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 14mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = -6.6A. (See fig.12)
- $\label{eq:loss_def} \ensuremath{\Im} \quad I_{SD} \leq \text{-}6.6A, \ di/dt \leq 620A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 300 \mu s$ ; duty cycle  $\leq 2\%$ .
- S When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 $\ \, \ \, \ \, \mbox{$\mbox{$\rm G$}$} \ \, \mbox{$\mbox{$\rm R$}$}_{\mbox{$\rm \theta$}}$  is measured at  $T_J$  of approximately  $90^{\circ}\mbox{$\mbox{$\rm C$}$}$ 



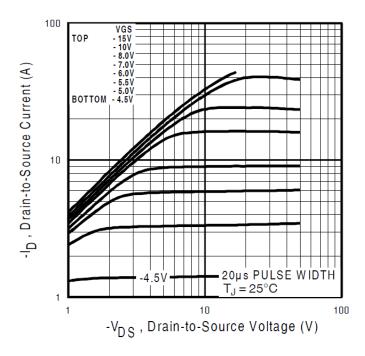


Fig. 1 Typical Output Characteristics

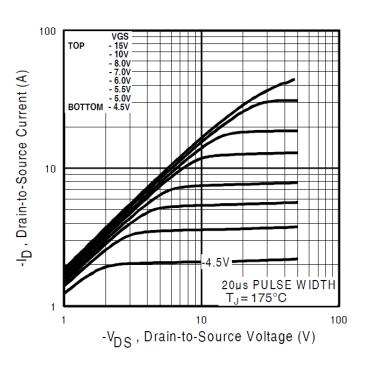


Fig. 2 Typical Output Characteristics

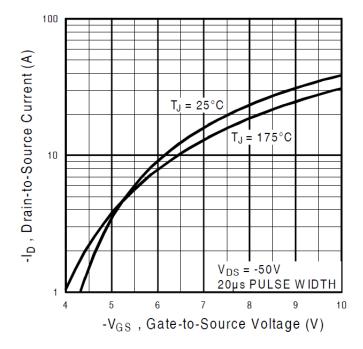
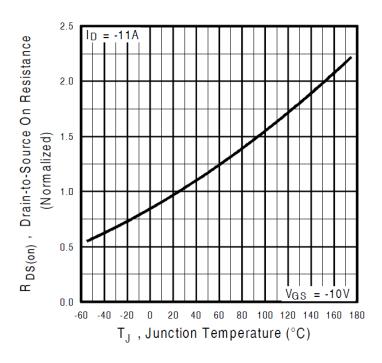
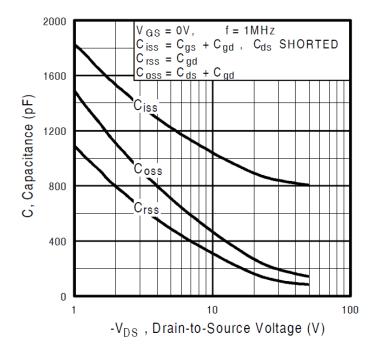


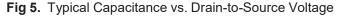
Fig. 3 Typical Transfer Characteristics



**Fig. 4** Normalized On-Resistance vs. Temperature







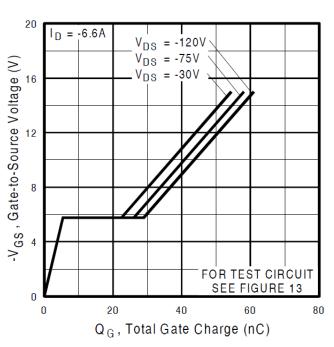
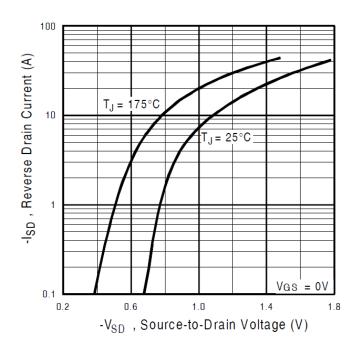


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



**Fig. 7** Typical Source-to-Drain Diode Forward Voltage

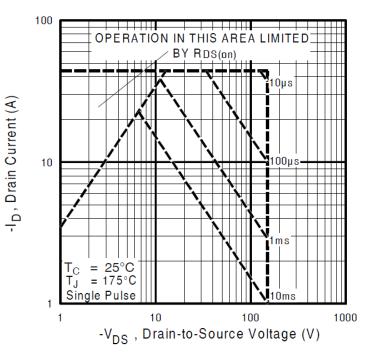
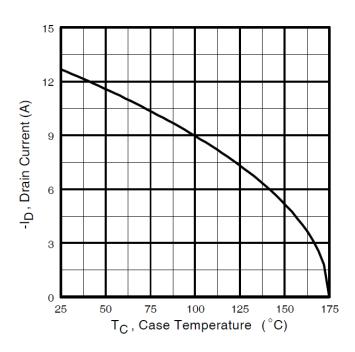


Fig 8. Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current vs. Case Temperature

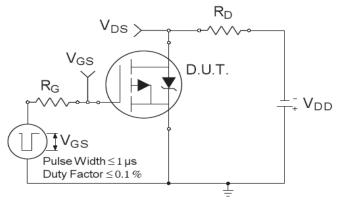


Fig 10a. Switching Time Test Circuit

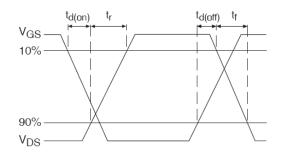


Fig 10b. Switching Time Waveforms

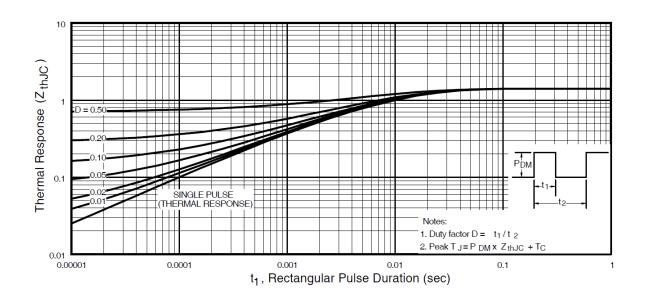


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



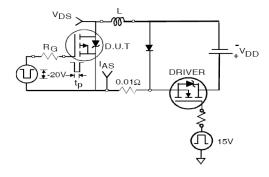


Fig 12a. Unclamped Inductive Test Circuit

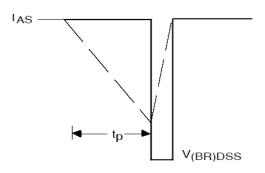


Fig 12b. Unclamped Inductive Waveforms

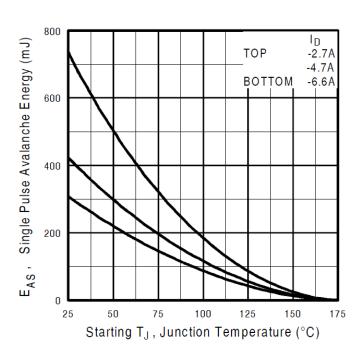


Fig 12c. Maximum Avalanche Energy vs. Drain Current

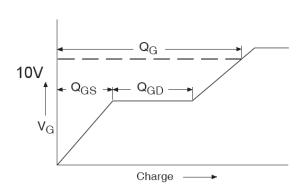


Fig 13a. Gate Charge Waveform

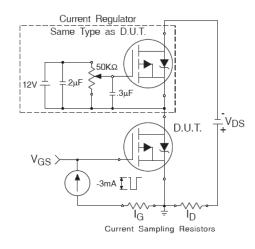
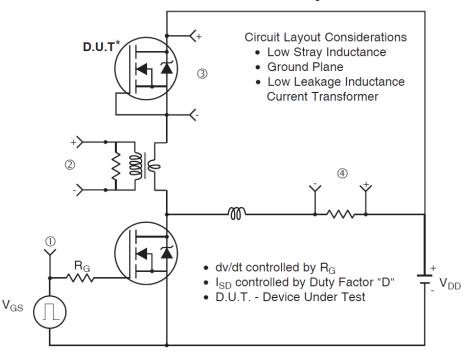


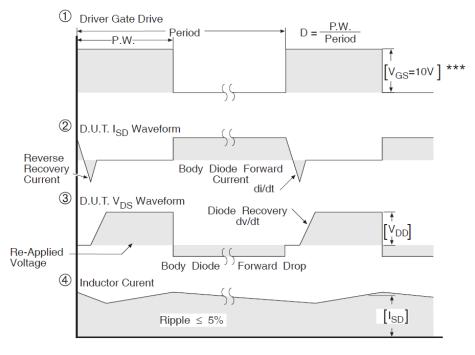
Fig 13b. Gate Charge Test Circuit



# Peak Diode Recovery dv/dt Test Circuit



<sup>\*</sup> Reverse Polarity of D.U.T for P-Channel

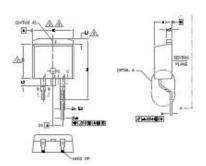


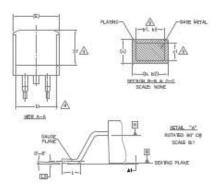
\*\*\*  $V_{GS}$  = 5.0V for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for P-Channel HEXFET® Power



## D<sup>2</sup> - Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





NOIES:
1. DIMENSIONING AND TOLERANCING PER ASIAE Y14.5W-1994
2. DIVENSIONS ARE SHOWN IN WILLIMETERS [INCHES].
A DIMENSION D & E OO NOT INCLUDE WOLD FLASH, WOLD FLASH SHALL NOT EXCEED 0.127 [.006"] PER SIDE. THESE DIMENSIONS ARE WEASURED AT THE OUTWOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
THERWAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
DIMENSION 61, 65 AND 61 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.

S Y	DIMENSIONS
250	

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y		DIMEN	SIONS		N
M B	MILLIN	ETERS	INC	HES	P
0	MIN.	MAX.	MIN.	MAX.	E S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
ь2	1.14	1.78	.045	.070	
Ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	_	4
Ε	9.65	10.67	.380	,420	3,4
E1	6,22	-	.245	-	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	-	1.68	12.00 mm	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

#### LEAD ASSIGNATIONTS

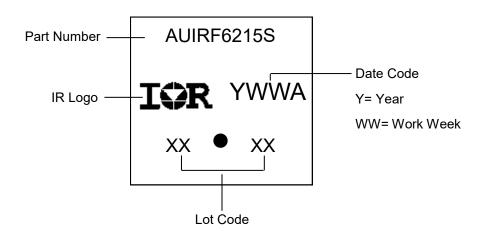
DICCES

I.- ANODE (TWO DIE) / DPEN (ONE DIE) 2. 4.- CATHODE 3.- ANODE

HENFET

IGHTs, CoPACK 1.— GATE 4.— DRAIN 3.— SOURCE 2, 4.- COLLECTOR 5.- EMITTER

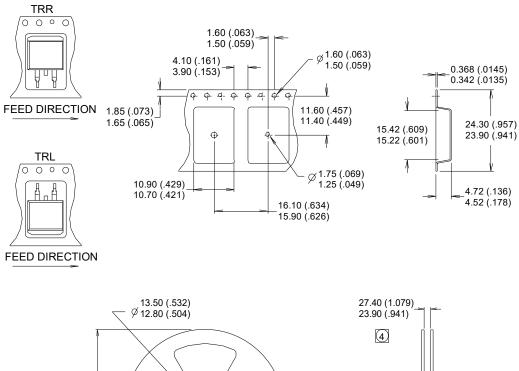
# D<sup>2</sup>- Pak (TO-263AB) Part Marking Information

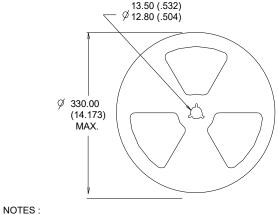


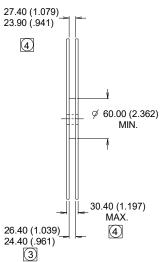
Note: For the most current drawing please refer to IR website at http://www.irf.com/packaging



## D<sup>2</sup>- Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/packaging">http://www.irf.com/packaging</a>



### **Qualification Information**

			Automotive				
			(per AEC-Q101)				
Qualification Level		Comments: Th	is part number(s) passed Automotive qualification. Infineon's				
		Industrial and C	Consumer qualification level is granted by extension of the higher				
		Automotive leve	el.				
Moisture	Sensitivity Level	D <sup>2</sup> -Pak	MSL1				
	Marilian Maria		Class M3 (+/- 400V) <sup>†</sup>				
	Machine Model	AEC-Q101-002					
<b>500</b>	Liver on Dady Madel	Class H1B (+/- 1000V) <sup>†</sup>					
ESD	Human Body Model	AEC-Q101-001					
			Class C5 (+/- 1125V) <sup>†</sup>				
Charged Device Model		AEC-Q101-005					
RoHS Compliant		Yes					

<sup>†</sup> Highest passing voltage.

### **Revision History**

Date	Rev.	Comments
11/13/2015	2.1	Updated datasheet with corporate template
		Corrected ordering table on page 1.
10/10/2017	2.2	Corrected typo error on part marking on page 8.
12/16/2020	2.3	Correct footer date (inconsistent date) on all pages
		Removed "HEXFET® Power MOSFET" -page1

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